Scope of Accreditation

(Measurement Method)

Accreditation Number: VLAC-010-2 Expiration Date: November 5, 2026

[Name of Laboratory]

FUJITSU LIMITED

[Test site name]

FUJITSU EVALUATION ENGINEERING LABORATORY SHINKAWASAKI

[Test site Address]

1-1 Shinogura, Saiwai-ku, Kawasaki-shi, Kanagawa, 212-8510 Japan

[Measurement Method]

Emission test

Radiated disturbance: Enclosure Port Disturbance electric field test

[Test Condition] On the reference ground plane, Measurement distance: 3 m / 10 m

Measurement Frequency Range: 30 MHz – 1 GHz

[Test Condition] Quasi Free Space

Measurement Frequency Range: 1 GHz - 40 GHz

Conducted disturbance measurement: AC mains port
Voltage measurement [Test condition] AMN

Conducted disturbance Measurement: Wired network port

Voltage measurement [Test condition] AAN, Capacitive voltage probe

Current measurement [Test condition] Current probe

Disturbance electric field test: Antenna port / RF modulator output port / Tuner port / Fiber port

Voltage test [Test condition] AAN, Capacitive voltage probe

Current test [Test condition] Current probe

Wanted signal and Voltage test at the RF output [Test condition] Selective voltmeter

Immunity test

Electro static discharge
Radiated electromagnetic field strength
Electrical fast transient/burst (EFT/B)
Surge

Contact discharge, Air discharge, Indirect discharge
Measurement Frequency range: 80 MHz – 6 GHz
Mains port, Telecommunication/Signal port
Mains port, Telecommunication/Signal port

RF conducted interference

Mains port measurement frequency range: 150 kHz - 80 MHz

Telecommunication/Signal port measurement frequency range: 150 kHz - 80 MHz

Radiated magnetic field

Interruptions and Voltage variations

Harmonic current

Harmonic current test

Voltage changes, Voltage fluctuations and Flicker test

Voluntary EMC Laboratory Accreditation Center Inc.

Scope of Accreditation

(Test standards)

Accreditation Number: VLAC-010-2 Expiration Date: November 5, 2026

[Name of Laboratory]

FUJITSU LIMITED

[Test site name]

FUJITSU EVALUATION ENGINEERING LABORATORY SHINKAWASAKI

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[Test standards]

Emission test

VCCI Technical requirements: VCCI-CISPR 32:2016*1
FCC 47 CFR Part 15 Subpart B: ANSI C63.4-2014 (up to 40 GHz)
CISPR 32:2015*1, EN 55032:2015*1, J55032(H29)*1, CISPRJ 32:2017*1
AS/NZS CISPR 32:2015*1, ICES-003(Issue 7), CNS 15936:2006*1
*1: Except for Annex H (Outdoor unit of home satellite receiving systems).
[Note-1] In emission testing, In-Situ are outside the scope of accreditation.

Immunity test

IEC 61000-4-2:2008 /-4-3:2006+A1:2007+A2:2010 /-4-4:2012 /-4-5:2014+A1:2017 /-4-6:2013 /-4-8:2009 /-4-11:2004
EN 61000-4-2:2009 /-4-3:2006+A1:2008+A2:2010 /-4-4:2012 /-4-5:2014+A1:2017 /-4-6:2014 /-4-8:2010 /-4-11:2004
CISPR 35:2016*2, EN 55035:2017+A11:2020*2
**2. Event for "Broadband impulsive conducted disturbances". A prov. E. (Networking)

*2: Except for "Broadband impulsive conducted disturbances", Annex F (Networking function), Annex G (Audio output function) and Annex H (Telephony function).

Harmonic Test in Public Low Voltage Systems

IEC 61000-3-2:2018, IEC 61000-3-3:2013+A1:2017*³, IEC 61000-3-11:2001, IEC 61000-3-12:2011 EN 61000-3-2:2019, EN 61000-3-3:2013+A1:2019*³, EN 61000-3-11:2001, EN 61000-3-12:2011 JIS C 61000-3-2:2019

Voluntary EMC Laboratory Accreditation Center Inc.

The laboratory is only accredited for testing activities outlined within the test methods listed above. If test standards do not include the edition, it means the latest one at the date of renewal (11.6, 2024).

^{*3:} Except for Annex A.1.2 and A.2.